

<b>Notice of References Cited</b>	Application/Control No. 10/534,082	Applicant(s)/Patent Under Reexamination HINUMA ET AL.	
	Examiner Rodney P. Swartz, Ph.D.	Art Unit 1645	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO200166734	09-2001	WIPO	Mukai et al	C12N 15/12
	O					
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**NON-PATENT DOCUMENTS**

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